

FORM PTO-1449
(REV. 7-80)U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICEATTY. DOCKET NO.
12336/7:1APPLICATION NO.
10/092,343APPLICANTS: Koichi Mukasa, Makoto Sawamura,
Kazuhsia Sueoka, and Eiichi HirotaFILING DATE
March 5, 2002GROUP
-2878 2881 -cmkINFORMATION DISCLOSURE CITATION
(Uses several sheets if necessary)

U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
AA						
AB						
AC						
AD						
AE						
AF						
AG						
AH						
AI						
AJ						
AK						

FOREIGN PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
						YES	NO
cmk	AL 2001264230 A	26.09.01	Japan	G01N	13/16	abstract only	
	AM						
	AN						
	AO						
	AP						

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)

cmk	AR	K. Sueoka and K. Mukasa, <i>Development of Spin-Dependent Scanning Tunneling Microscopy</i> , School of Engineering, Hokkaido University and CREST, JST, Vol. 24, No. 12, 2000.
	AS	
	AT	

EXAMINER *Chris Kalwodz*DATE CONSIDERED *Dec 8, 2003*

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.